SHEET 1 OF 1

Form PTO 1449 (Modified)		U.S. DEPARTMENT PATENT AND TRAI		ATTY DOCKET NO.		SERIAL NO. 10/777, 748	
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APPLICANT  LIST OF REFERENCES CITED BY APPLICANT  Tochivuki FURLUF et al.							
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EXAMINER INITIAL		DOCUMENT NUMBER	DATE	NAME	CLASS	SUB CLASS	FILING DATE IF APPROPRIATE
LN	AA	5,926,012	07/20/99	Satoki TAKIZAWA, et al.	323	284	
LN	AB	6,271,709 B1	08/07/01	Shin KIMURA, et al.	327	434	
	AC						
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		DOCUMENT NUMBER	DATE	COUNTRY		TRANSLATION	
LN	AO	3-93457	04/18/91	Japan (with English Extract)		YES	NO X
w	AP	6-291631	10/18/94	Japan (with English Abstract)			$\frac{\hat{x}}{x}$
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LN 1	AR	10-150764	06/02/98	Japan (Corresponding U.S. Patent 5,9	26.012)		×
in	AS	2000-228868	08/15/00	Japan (Corresponding U.S. Patent 6,2			×
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	AU						
	AV						
OTHER REFERENCES (Including Author, Title, Date, Pertinent Pages, etc.)							
1							
	AW						
	AX						
	AY						
	ΑZ				Additional References sheet(s) attached		
Examiner Long Nguyen					Date Considered 9/20/05		
*Examiner: Initial if reference is considered, whether or not citation is in conformance with MPEP 609; Draw line through citation if not in							
conformance and not considered. Include copy of this form with next communication to applicant.							